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# Miniature 6-axis force torque sensor MMS101 Data Sheet

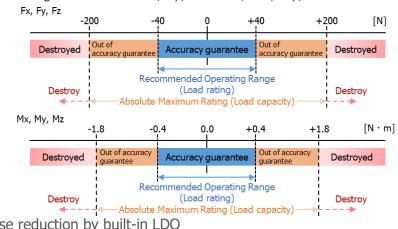
#### DESCRIPTION



This is a 6-axis force torque sensor which has 3-axis force and 3-axis moment. It has a hybrid structure of a MEMS chip and a metal structure, realizing 6-axis detection. This product has AFE ICs built in its module and produces digital output (SPI). Correction coefficients used for matrix operation (other axis interference components are removed) are stored in memories inside the AFE ICs. Since they can be read out immediately before the measurement start, users do not have to control the sensor and the correction coefficients. Additionally, the LDO built in the module reduces noises. This product is extremely small and light, suitable for fingertips of robot hands.

#### **FEATURES**

- Very small:  $\Phi$ 9.6(W) × 9.0(H) mm
- Light weight: 3 g
  - High load capacityFx, Fy, Fz: 200N / Mx, My, Mz: 1.8N•mLoad ratingFx, Fy, Fz: 40N / Mx, My, Mz: 0.4N•m



Top Side 9.0mm Bottom 50mm Fig. 1 Product appearance

- Noise reduction by built-in LDO Fx, Fy:0.04N RMS / Fz:0.06N RMS Mx, My:0.0004N•m RMS / Mz:0.0008N•m RMS
- Digital output of 6-axis data by built-in sequencer (SPI)
- RoHS compliant
- Halogen-contained

## MODEL NUMBER

MMS101BXXA

\*Before installing and using this product, please carefully read "<u>PRECAUTIONS FOR SENSOR INSTALLATION</u>" and <u>"PRECAUTIONS FOR SENSOR HANDLE</u>" in this document. Otherwise, incorrect installation may cause damage to this product.

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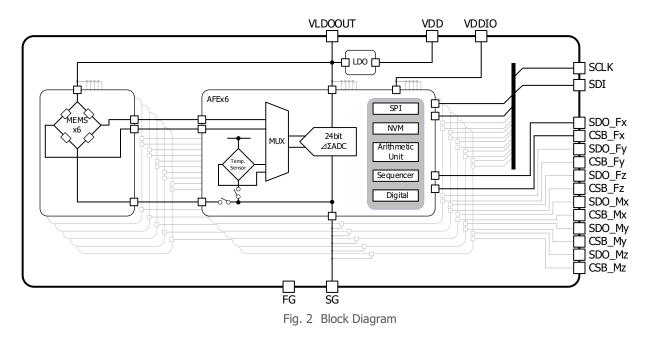
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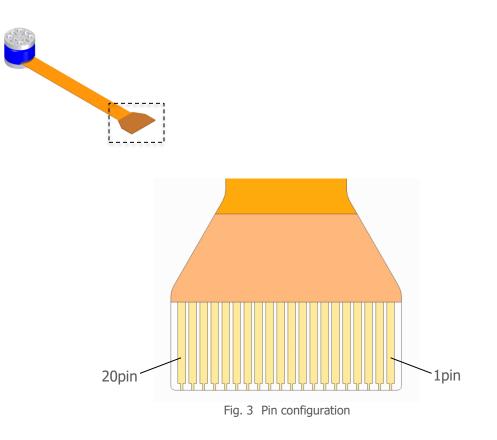
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## **BLOCK DIAGRAM**

This product has six AFEs corresponding to each axis. Please switch CSB pin voltage level to access each AFE for operation.



#### PIN CONFIGURATION



\*The terminal are located on the back of the FPC. The above finger is a perspective view.

# TERMINAL EXPLANATIONS

Table 1 Pin table							
No.	Pin Name	Туре	Function				
1	FG	-	Frame ground				
2	FG	-	Frame ground				
3	CSB_Fz	Ι	AFE3(Fz) Chip select for SPI communication (negative logic)				
4	SDO_Fz	0	AFE3(Fz) Serial Data Output for SPI communication				
5	CSB_Mz	Ι	AFE6(Mz) Chip select for SPI communication (negative logic)				
6	SDO_Mz	0	AFE6(Mz) Serial Data Output for SPI communication				
7	CSB_Mx	Ι	AFE4(Mx) Chip select for SPI communication (negative logic)				
8	CSB_My	Ι	AFE5(My) Chip select for SPI communication (negative logic)				
9	VDDIO	Ι	Digital I/O power supply				
10	VLDOOUT	0	Built-in LDO output * Not-in-use during normal operation. However, it is recommended to connect a capacitor (10uF) near the sensor connection cable connector on your circuit board for noise reduction.				
11	VDD	Ι	Analog power supply				
12	SG	-	Signal ground				
13	CSB_Fx	Ι	AFE1(Fx) Serial Data Output for SPI communication				
14	SCLK	Ι	Serial clock for SPI communication				
15	SDO_Fy	0	AFE2(Fy) Serial Data Output for SPI communication				
16	SDI	Ι	Serial Data Input for SPI communication				
17	SDO_My	0	AFE5(My) Serial Data Output for SPI communication				
18	SDO_Fx	0	AFE1(Fx) Serial Data Output for SPI communication				
19	SDO_Mx	0	AFE4(Mx) Serial Data Output for SPI communication				
20	CSB_Fy	Ι	AFE2(Fy) Chip select for SPI communication (negative logic)				

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# ABSOLUTE MAXIMUM RATINGS

# (unless otherwise specified, $Ta = 25^{\circ}C$ )

Item	Symbol	Min.	Max.	Unit
Load capacity	Fmax	-200	200	Ν
	M <sub>MAX</sub>	-1.8	1.8	N∙m
Storage temperature range	Tstg	-10	+60	°C
Analog supply voltage	VDD <sub>MAX</sub>	-0.3	+15	V
Digital I/O voltage	VDDIO <sub>MAX</sub>	-0.3	+4.0	V

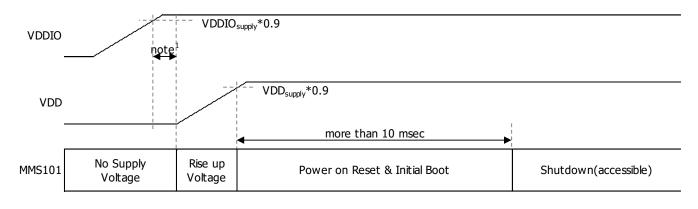
# RECOMMENDED OPERATING CONDITIONS

#### (unless otherwise specified, $Ta = 25^{\circ}C$ )

(anicos ocherwise specifica) i	5			
Item	Symbol	Min.	Max.	Unit
Load rating	Forr	-40	40	Ν
Load Fating	Mopr	-0.4	0.4	N∙m
Operating temperature range	Topr	+5	+45	Ĉ
Analog supply voltage	VDDopr	+3.8	+14	V
Digital I/O voltage	VDDIOOPR	+1.14	+3.6	V

Power-on sequence

There is no specification for the power-on sequence of both VDD and VDDIO supplies. When the power is turned on, access the device at least 10msec after both VDD and VDDIO supplies have reached 90% of the applied voltage.





note<sup>1</sup>: No time is specified from starting VDDIO to input VDD. There is no problem even if the power-on sequence of both VDD and VDDIO supplies is reversed.

# FORCE TORQUE SENSOR CHARACTERISTICS

Item Symbol		Symbol	Condition	Min.	Тур.	Max.	Unit.
Theoretical	FxFyFz	Fres	-	-	0.001	-	Ν
resolution	MxMyMz	M <sub>RES</sub>	-	-	0.00001	-	N∙m
	FxFy	F <sub>Eresxy</sub>	-	-	0.04	-	N RMS
Effective resolution	Fz	F <sub>Eresz</sub>	-	-	0.06	-	N RMS
(note <sup>2</sup> )	MxMy	MEresxy	-	-	0.0004	-	N∙m RMS
	Mz	M <sub>Eresz</sub>	-	-	0.0008	-	N∙m RMS
Linea (note		F∟ M∟	FS=40N or 0.4N∙m	-1.0	-	1.0	%FS
Hyster (note		F <sub>Hys</sub> M <sub>Hys</sub>	FS=40N or 0.4N∙m	-1.0	-	1.0	%FS
Accuracy (note <sup>2</sup> ) Conversion time (note <sup>3</sup> ) Latency (note <sup>3</sup> )		F <sub>Acc</sub> M <sub>Acc</sub>	FS=40N or 0.4N∙m	-5.0	-	5.0	%FS
		t <sub>con</sub>	-	-	781.25	-	usec
		t <sub>lat</sub>	Conversion time: Typ. Communication clock: 1MHz No delay in switching of AFE to access	-	-	2.0	msec

(unless otherwise specified,  $Ta = 25^{\circ}C$ , VDD = 3.8 to 14 V, VDDIO = 1.14 to 3.6 V)

note<sup>2</sup>: The values in chart are the results of the measurement using our evaluation equipment and board. note<sup>3</sup>: Design assurance item

Definition of Force Torque Sensor Characteristics

- Full Scale FS Full-scale FS is 40N or 0.4N•m from zero to the load rating for positive and negative.
- Theoretical resolution The value is equivalent to 1LSB of output data.
- Effective resolution

Standard deviation of 500-point data acquired after measurement is started with no load and the output is stabled.

Linearity

Deviation from Reference line connecting the output between no load state and  $+40N (0.4N \cdot m)$  applied state or  $-40 N (0.4N \cdot m)$  applied state.

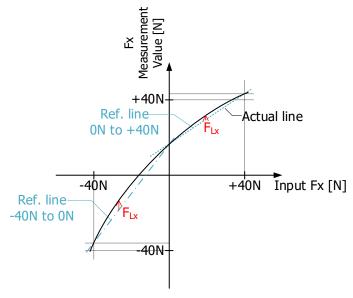
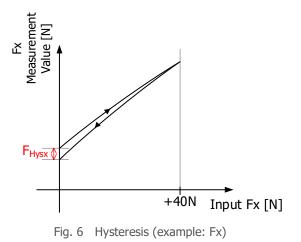


Fig. 5 Linearity (example: Fx)

Hysteresis

Change amount from the origin after having applied the load ratings (+40N (0.4N·m) or -40N (-0.4N·m)).



Accuracy

Deviation of the applied load and output when a load is applied to the main axis while the offset output in the unloaded state is canceled.

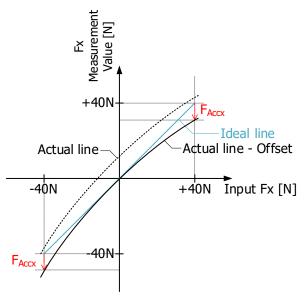


Fig. 7 Accuracy (example: Fx)

- Conversion time Update interval of ADC data output from each AFE
- Latency

Delay time from the timing of output data measurement to the timing of matrix operation completion.

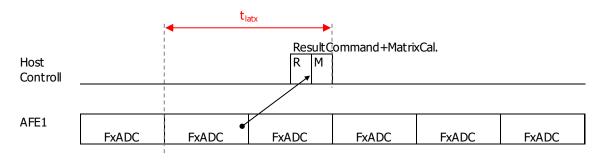


Fig. 8 Latency (example: Fx)

## ELECTRICAL CHARACTERISTICS

# Analog Characteristics

(unless otherwise specified,  $Ta = 25^{\circ}C$ , VDD = 4.3 V, VDDIO = 3.3 V)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit.
VDD Current consumption	$I_{\text{VDDact}}$	Measure active	-	-	10	mA
VDDIO Current consumption	$I_{\text{VDDIOact}}$	Measure active	-	-	20	uA

# Digital I/O Characteristics

(unless otherwise specified,  $Ta = 25^{\circ}C$ , VDD = 3.8 to 14 V, VDDIO = 1.14 to 3.6 V)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
High level Input voltage	h level Input VIH -		$0.8 \times VDDIO$	-	VDDIO + 0.3	V
Low level Input voltage	V <sub>IL</sub>	-	-0.3	-	$0.2 \times VDDIO$	V
Output voltage	V <sub>OH1</sub>	$VDDIO \ge 2.0V,$ Iload = -3mA	VDDIO - 0.4	-	-	V
High level	V <sub>OH2</sub>	VDDIO < 2.0V, Iload = -1mA	$0.8 \times VDDIO$	-	-	V
Output voltage	V <sub>OL1</sub>	VDDIO ≧ 2.0V, Iload = 3mA	-	-	0.4	V
Low level	V <sub>OL2</sub>	VDDIO < 2.0V, Iload = 1mA	-	-	$0.2 \times VDDIO$	V

#### **FUNCTION**

#### **Operation Description**

MMS101 can acquire data following the operation flow shown below.

Correction coefficients used in the matrix operation are stored in the memory (NVM: Non-Volatile Memory) built in each AFE. Reading out the correction coefficients before issuance of measurement start instruction allows the matrix operation after ADC data of each axis is acquired.

ADC data offset changes depending on ambient temperature. If needed, temperature sensor values used for offset correction arithmetic done in each AFE should be updated at any timing.

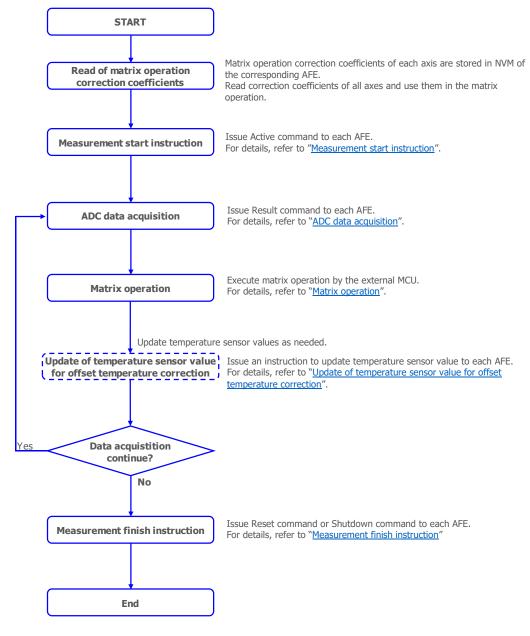


Fig. 9 Operation flow chart

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#### Read of matrix operation correction coefficients

Matrix operation correction coefficients are stored in the memory (NVM: Non-Volatile Memory) built in each AFE. Please read the matrix operation correction coefficient 1 to 6 (3 bytes / 24 bits) shown in Table 3 from all AFEs. These coefficients can be read by executing NVM read command. To execute this command, AFEs must be in the Idle state. Therefore, Idle command must be issued and executed in advance. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>".

NVM Addr.			Symbols in	Matrix ope	ration form	ula (note <sup>4</sup> )	
NVM Adul.		AFE1	AFE2	AFE3	AFE4	AFE5	AFE6
5Ah	MSB						
5Bh	Matrix operation correction coefficient 1	A1	B1	C1	D1	E1	F1
5Ch	LSB						
5Dh	MSB						
5Eh	Matrix operation correction coefficient 2	A2	B2	C2	D2	E2	F2
5Fh	LSB						
60h	MSB						
61h	Matrix operation correction coefficient 3	A3	B3	C3	D3	E3	F3
62h	LSB						
63h-6Bh	For Manufacturer						
6Ch	MSB						
6Dh	Matrix operation correction coefficient 4	A4	B4	C4	D4	E4	F4
6Eh	LSB						
6Fh	MSB						
70h	Matrix operation correction coefficient 5	A5	B5	C5	D5	E5	F5
71h	LSB						
72h	MSB						
73h	Matrix operation correction coefficient 6	A6	B6	C6	D6	E6	F6
74h	LSB						

Table 2	NI/M	man	of	matrix	operation	correction	coefficients
I able Z	11 1 1 1	map	0I	mauix	operation	COLLECTION	coefficients

note<sup>4</sup>: For details of matrix operation formula, refer to "Matrix operation".

Measurement start instruction

Each AFE starts AD conversion when receiving Active command. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 10 schematically shows an example of AD conversion start instruction issued to AFE1. This instruction must be issued to all AFEs because matrix operation uses ADC data of all axes.

ADC data is subject to offset temperature correction in each AFE. Approximately 7.5 msec is required to complete the first AD conversion because of temperature sensor measurement for offset temperature correction and waiting for filter stabilization. From the second AD conversion, the conversion is repeated at the interval of approximately 0.8 msec because neither the temperature sensor measurement nor waiting for filter stabilization is required.

Drift occurs in Fz (AFE3) immediately after the AD conversion start. In this case, it is recommended that data is acquired after waiting approximately 5 min for stabilization.

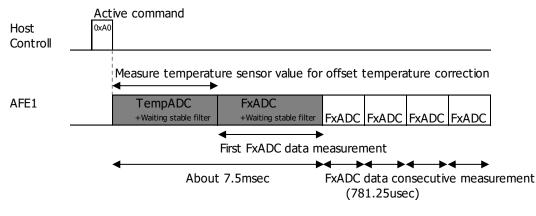


Fig. 10 Schematic of AD conversion start instruction

The second and subsequent ADC data are subject to offset temperature correction using temperature sensor values acquired during the initial AD conversion. This makes correction error larger with changes in ambient temperature, requiring regular update of the temperature sensor values. For update of temperature sensor values, refer to "Update of temperature sensor value for offset temperature correction".

#### ADC data acquisition

To acquire ADC data (3 bytes / 24 bits), Result command should be issued to each AFE. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 11 schematically shows an example of ADC data acquisition from AFE1. Result command must be issued to all AFEs to acquire ADC data of all axes because matrix operation uses this data.

Each AFE returns the last AD-converted data when receiving Result command. If Result command is issued during the first AD conversion, ADC data will be 000000 h.

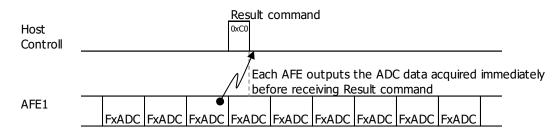
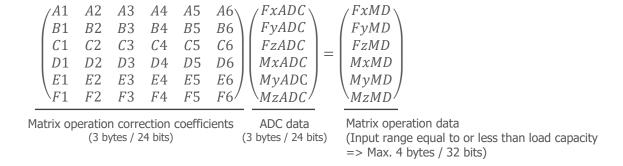


Fig. 11 Schematic of ADC data acquisition

Matrix operation

Please execute the matrix operation below by an external MCU, using matrix operation correction coefficients (3 bytes / 24 bits) and ADC data (3 bytes / 24 bits).

Matrix operation formula (note<sup>5</sup>)



Matrix operation data FxMD to MxMD should be right-shifted by 11 bits to convert the force into 0.001\*N and the moment into 0.00001\*N·m.

$$\begin{split} & Fx = FxMD \div 2^{11} \ [0.001^*N] \\ & Fy = FyMD \div 2^{11} \ [0.001^*N] \\ & Fz = FzMD \div 2^{11} \ [0.001^*N] \\ & Mx = MxMD \div 2^{11} \ [0.00001^*N \cdot m] \\ & My = MyMD \div 2^{11} \ [0.00001^*N \cdot m] \\ & Mz = MzMD \div 2^{11} \ [0.00001^*N \cdot m] \end{split}$$

note<sup>5</sup>: Determinant expansion

 $\begin{aligned} FxMD &= A1 \times FxADC + A2 \times FyADC + A3 \times FzADC + A4 \times MxADC + A5 \times MyADC + A6 \times MzADC \\ FyMD &= B1 \times FxADC + B2 \times FyADC + B3 \times FzADC + B4 \times MxADC + B5 \times MyADC + B6 \times MzADC \\ FzMD &= C1 \times FxADC + C2 \times FyADC + C3 \times FzADC + C4 \times MxADC + C5 \times MyADC + C6 \times MzADC \\ MxMD &= D1 \times FxADC + D2 \times FyADC + D3 \times FzADC + D4 \times MxADC + D5 \times MyADC + D6 \times MzADC \\ MyMD &= E1 \times FxADC + E2 \times FyADC + E3 \times FzADC + E4 \times MxADC + E5 \times MyADC + E6 \times MzADC \\ MzMD &= F1 \times FxADC + F2 \times FyADC + F3 \times FzADC + F4 \times MxADC + F5 \times MyADC + F6 \times MzADC \end{aligned}$ 

• Matrix operation correction coefficient (A1 to F6)

Matrix operation correction coefficient is 3 bytes (24 bits). A negative number is expressed by 2's complement.

HEX.	DEC.
800000 h	-8388608
FFFFFF h	-1
000000 h	0
000001 h	1
000800 h	2048
7FFFFF h	8388607

Table 3 Example of matrix operation correction coefficient

· ADC data (FxADC to MzADC)

ADC data is 3 bytes (24 bits). A negative number is expressed by 2's complement.

HEX.	DEC.
800000 h	-8388608
FF63C0 h	-40000
FFFFFF h	-1
000000 h	0
000001 h	1
009C40 h	40000
7FFFFF h	8388607

Table 4	Example	of ADC	data	output
rabie i	Example	017.000	aaca	output

#### Matrix operation data (FxMD to MzMD)

According to calculations, the range of the matrix operation data is 6 bytes (48 bits). For the data measured at the load capacity or less, the range is 4 bytes (32 bits) at the maximum. The matrix operation data uses negative numbers expressed by 2's complement.

Matrix operation data	Matrix ope After right-sh	Force		
HEX.	HEX.	DEC.	[N]	
E7960000 h		-		
S	FFFCF2C0 h	-200000	-200.000	
E79607FF h				
FB1E0000 h				
S	FFFF63C0 h	-40000	-40.000	
FB1E07FF h				
FFFFF800 h			0.00/	
۲	FFFFFFF h	-1	-0.001	
FFFFFFF h				
00000000 h	0000000 h	0	0.000	
000007FF h	00000000 h	0	0.000	
000007FF II 00000800 h				
2	00000001 h	1	0.001	
00000FFF h	000000111	Ĩ	0.001	
04E20000 h				
S	00009C40 h	40000	40.000	
04E207FF h				
186A07FF h				
S	00030D40 h	200000	200.000	
186A0000 h				

#### Table 5 Example of matrix operation data – force output

Table 6 Example of matrix operation data - moment output						
Matrix operation data	Matrix ope After right-sh	Moment				
HEX.	HEX.	DEC.	[N•m]			
EA070000 h						
S	FFFD40E0 h	-180000	-1.80000			
EA0707FF h						
FB1E0000 h						
S	FFFF63C0 h	-40000	-0.40000			
FB1E07FF h						
FFFFF800 h						
S	FFFFFFF h	-1	-0.00001			
FFFFFFF h						
00000000 h						
S	00000000 h	0	0.00000			
000007FF h						
00000800 h						
S	00000001 h	1	0.00001			
00000FFF h						
04E20000 h						
2	00009C40 h	40000	0.40000			
04E207FF h						
15F907FF h						
2	0002BF20 h	180000	1.80000			
15F90000 h						

Table 6 Example of matrix operation data - moment output

#### Measurement finish instruction

Each AFE completes AD conversion and ends measurement when receiving Reset command or Shutdown command. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 12 schematically shows an example of measurement finish instruction issued to AFE1. Measurement finish instruction must be issued to all AFEs.

Host Controll						Res 0x72 or 0x90	et or Shutdown command
AFE1	 FxADC	FxADC	FxADC	FxADC	FxADC		Shift to Shutdown state

Fig. 12 Schematic of measurement finish instruction

Update of temperature sensor value for offset temperature correction

After AD conversion starts, the second and subsequent ADC data are subject to offset temperature correction using temperature sensor values acquired during the first AD conversion. This makes correction error larger with changes in ambient temperature, requiring regular update of the temperature sensor values.

Write Register command is used to update temperature sensor values for offset temperature correction. Fig. 13 schematically shows an example of the update of such data in AFE1. By executing Write Register command and writing data 0x01 to register address 0x3F at any timing, on-going AD conversion is completed, AD conversion of the temperature sensor is done again, and the data is updated. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>".

The last ADC data can also be acquired during update of the temperature sensor values.

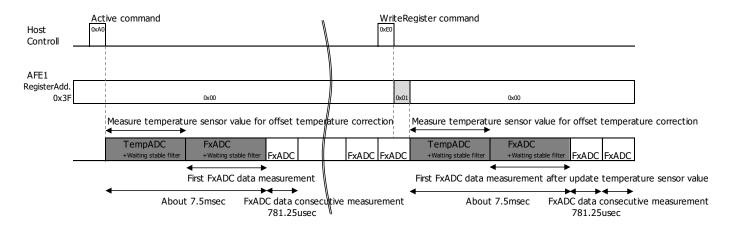
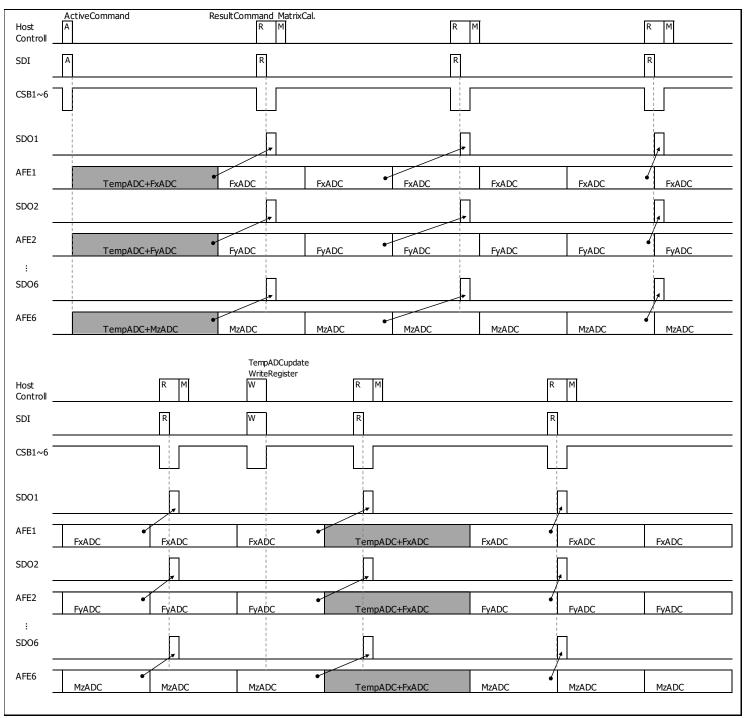


Fig. 13 Schematic of update of temperature sensor values for offset temperature correction

Measurement timing chart



<sup>\*</sup>AD conversion cycle depends on AFE because internal clock is different from each AFE. Fig. 14 Integrated CSB pin - Measurement timing chart

Host Controll	Active Result Command Comman		Result M Command	Result M Command
SDI	A         A         R         R           1         2          6         1         2		R R R 1 26	R R R 1 26
SDO1~6		, ,		
CSB1				
AFE1	TempADC+FxADC FxADC	FxADC FxADC	FxADC FxADC	FxADC
CSB2		′		
AFE2	TempADC+FyADC FyADC	FyADC FyADC	FyADC FyAD	c FyADC
: CSB6				
AFE6				
	TempADC+MzADC MzADC	MzADC MzAI	DC MzADC N	MZADC MZADC
Host Controll	Result M TempADCu Command WriteRegis		Result Command	М
SDI	R         R         R         W         W           1         2          6         1         2	W R R R 6 1 2 6	R R R 1 26	
SDO1~6				,
CSB1				
AFE1	FxADC FxADC FxADC	/TempADC+FxADC	FxADC	FxADC
CSB2				
AFE2	FyADC FyADC FyADC	TempADC+FyADC	FyADC FyADC	FyADC
: CSB6				
AFE6	MzADC MzADC Mz	ZADC TempADC+MZAD	DC MzADC Mz	ADC MzADC

\*AD conversion cycle depends on AFE because internal clock is different from each AFE. Fig. 15 Integrated SDO pin - Measurement timing chart

# COMMAND CODE

				Table	7 Com	mand c	ode list			
	Comm	and Co	de							
Command Name	BIN.						Format			
	HEX.	C7	C6	C5	C4	C3	C2	C1	C0	
	0x72	0	1	1	1	0	0	1	0	SPI Write format
Reset							ecome	s busy	for the	e maximum 1.8msec.
	0x90	tion on		Comma 0	nd cod	e. 0	0	0	0	SPI Write format
Shutdown		o Shuta	0	÷	1	0	0	Ū	0	SFT White format
		tion on	ly with	comma	and cod	e.	1	T	T	
Idlo	0x94	1	0	0	1	0	1	0	0	SPI Write format
Idle					and pu and cod		he Idle	e state.		
	0xA0	1	0	1	0	0	0	0	0	SPI Write format
Active		D conv					1	1		•
	Operat 0xC0	tion on 1	1		and cod		0	0	0	CDI Write (Dond format
		4	1 Nutes /	0 24 bits)	0 is outr	0 ut MSI	0 B first	0	0	SPI Write/Read format
Read ADC Result	ADC data (3 bytes /24 bits) is output MSB first. A negative number is expressed by 2's complement. For output range, positive output is 000000 h to 7FFFFF h (0 to +8388607 in decimal number), while negative output is FFFFFF h to 800000 h (-1 to -8388608 in decimal number). However, the measurement data acquired during the usage beyond the recommended operating conditions cannot be guaranteed.									
	0xC2	1	1	0	0	0	0	1	0	SPIWrite/Read format
Read Temperature ADC Result	ADC data (3 bytes /24 bits) is output MSB first.         A negative number is expressed by 2's complement.         For output range, positive output is 000000 h to 7FFFFF h (0 to +8388607 in decimal number), while negative output is FFFFFF h to 800000 h (-1 to -8388608 in decimal number).         However, the measurement data acquired during the usage beyond the recommended operating conditions cannot be guaranteed.         Temperature value[°C] = DEC./2^16         Output example         BIN.       HEX.       DEC.         Temperature									
				000000			00 h	16384		5.000°C 25.000°C
				000000			000 h	2949		45.000°C
	0xE0	1	1	1	0	0	0	0	0	SPI Write format
Write Register	After s bits.	ending	comm				e order	of mei	mory a	ddress of 8 bits and write data of 8
Road NVM	0xD6	1	1	0	1	0	1	1	0	SPI Write/Read format (Busy)
Read NVM	It is us	sed for	readin	g matrix	x opera	tion co	rrectio	n coeffi	cients.	

Table 7 Command code list

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MITSUMI ELECTRIC CO., LTD. Semiconductor Div.

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#### STATE TRANSITION DIAGRAM

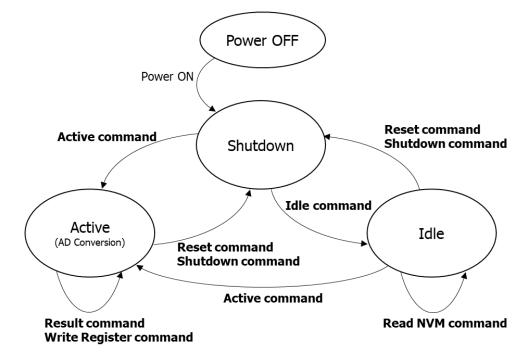


Fig. 16 State transition diagram

Table 8 State transition table							
State Command	Shutdown	Active	Idle				
Reset	Power on Reset & Initial Boot =>Shutdown state	Power on Reset & Initial Boot =>Shutdown state	Power on Reset & Initial Boot =>Shutdown state				
Shutdown	=>Keep state	=>Shutdown state	=>Shutdown state				
Active	Reset & Boot Load =>Active state (AD conversion)	Ignore(note <sup>6</sup> ) =>Keep state	=>Active state (AD conversion)				
Result	Ignore(note <sup>6</sup> ) =>Keep state	Output result =>Keep state	Do not issue(note <sup>7</sup> ) =>Keep state				
Idle	Reset & Boot Load =>Idle state	Do not issue(note <sup>8</sup> ) =>Idle state	=>Keep state				
Write Register	Ignore(note <sup>6</sup> ) =>Keep state	Temperature ADC update =>Keep state	Do not issue(note <sup>9</sup> ) =>Keep state				
Read NVM	Ignore(note <sup>6</sup> ) =>Keep state	Do not issue(note <sup>8</sup> ) =>Keep state	Output Matrix coeff. =>Keep state				

Table 8 State transition table

note<sup>6</sup>: NACK is returned to the command.

note<sup>7</sup>: The correct result is not output. Additionally, ACK is returned to the command.

note<sup>8</sup>: Although command is acceptable, it goes unintended behavior since sequence is running.

note<sup>9</sup>: Although command is acceptable, it goes unintended behavior during sequence execution.

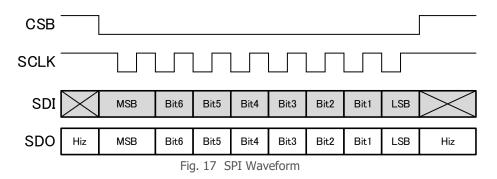
#### SERIAL INTERFACE

Table 9 Baud rate								
Items	Symbol	Condition	Min.	Тур.	Max.	Unit.		
	<b>BR</b> <sub>SPI1</sub>	$\begin{array}{c} BR_{SPI1} \\ Cb \leq 100 pF \end{array}$		-	5.0			
SPI communication speed	BR <sub>SPI2</sub> VDDIO < 2.0V Cb < 100pF		-	-	1.0	Mbps		
	BR <sub>SPI3</sub>	$\begin{array}{l} \text{VDDIO} \geqq 2.0\text{V}\\ \text{Cb} \leqq 400\text{pF} \end{array}$	-	-	2.5	Mups		
	BR <sub>SPI4</sub>	VDDIO < 2.0V Cb < 400pF	-	-	0.5			

It supports SPI as an interface for serial communication.

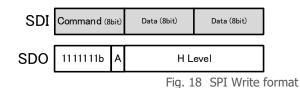
#### SPI format

The basic format of SPI is shown below. The relationship between clock (SCLK) and data (SDI/SDO) is Mode3.Data send/receive is started when CSB becomes low level from the status when SCLK is high level. Data is updated on falling edges of the SCLK, and sampled on rising edges of the SCLK. Data send/receive is ended when CSB becomes high level from the status when SCLK is high level.



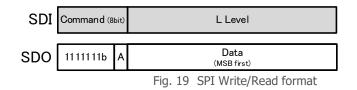
SPI Write format

Please send command code of 8 bits. When the command is received, it turns over ACK to 8 bits. If there is data, please continue sending.



#### SPI Write/Read format

Please send command code of 8 bits. When the command is received, it turns over ACK to 8 bits and it outputs the data MSB first.



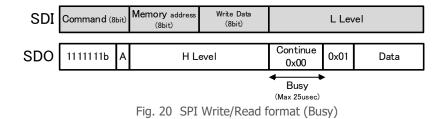
#### SPI Write/Read format (Busy)

Please send command code of 8 bits. When their commands are received, it turns over ACK to 8 bits. Then, please send memory address of 8 bits. After receiving the memory address, the internal area becomes busy for 25usec at the maximum in order to prepare for data transmission. During this time, it returns 0x00 which indicates busy state. When data preparation is completed, it outputs 0x01, followed by data of 8 bits.

#### How to discern busy state:

Please continue clock input in the same communication status after transmitting the write data. Then, it returns 0x00 which indicates busy status. It returns 0x01 when writing is completed.

\* 0x00 to indicate busy may sometimes be output or not depending on the clock frequency.



## SPI ACK

When command code which is send in each SPI format is received, it outputs L level to 8 bits as ACK. If command code is not accepted or command code is not valid, it outputs H level to 8 bits as NACK.

# SPI AC Characteristics

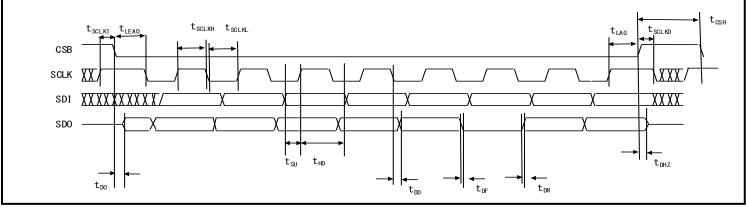
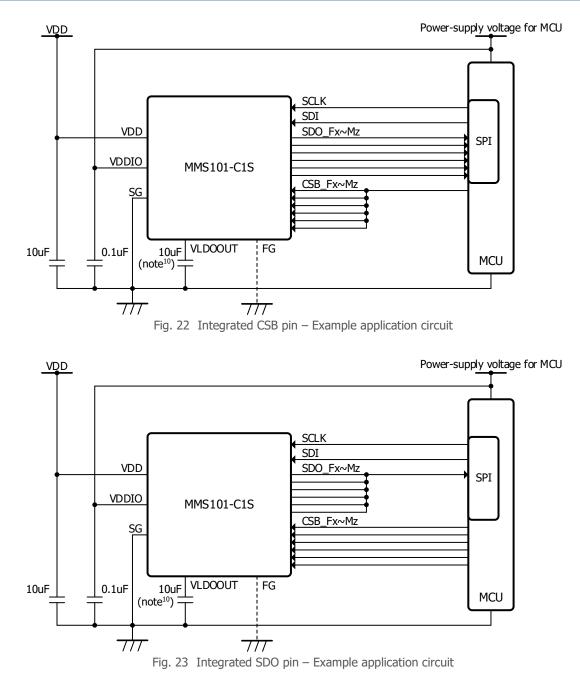


Fig. 21 SPI AC timing chart

Table 1(	N SPT	ΔC	Characteristics
I able I	J 3PI	AC	Characteristics

Items	Symbol	VDDI	0<2V	VDDI	Unit.	
Items	Symbol	min.	max.	min.	max.	Unit.
SCLK frequency(Duty 50±10%)	<b>f</b> sclk	-	1	-	5	MHz
SCLK High period (90%~90%)	tsclkh	400	-	80	-	ns
SCLK Low period(10%~10%)	tsclkl	400	-	80	-	ns
SCLK wait time	tsclki	500	-	100	-	ns
SCLK Delay time	tsclkd	0	-	0	-	ns
CSB High period(90%~90%)	tcsн	1000	-	200	-	ns
Time from CSB falling to SCLK falling	tlead	0	-	0	-	ns
Time from SCLK rising to CSB rising	tlag	500	-	100	-	ns
SDI setup time	tsu	100	-	10	-	ns
SDI hold time	t <sub>HD</sub>	10	-	10	-	ns
SDO rise time(Load 100pF) (10%~90%)	t <sub>DR</sub>	-	50	-	50	ns
SDO fall time(Load 100pF) (10%~90%)	t <sub>DF</sub>	-	50	-	50	ns
SDO output delay time(Load 100pF)	t <sub>DD</sub>	-	120	-	60	ns
SDO output delay time from CSB falling (Load 100pF)	t <sub>DO</sub>	-	120	-	60	ns
Time from CSB rising to SDO output HiZ (Load 100pF)	tdhz	-	170	-	170	ns

#### TYPICAL APPLICATION CIRCUIT



 $note^{10}$ : It is recommended to be placed as close as possible for noise reduction.

#### DIMENSIONS

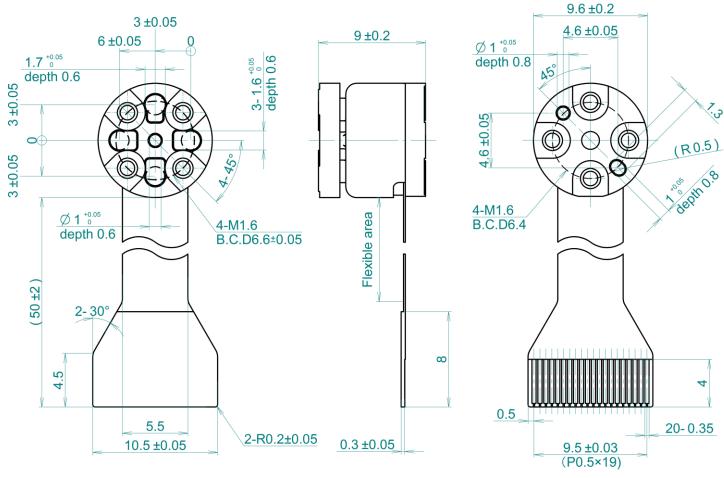


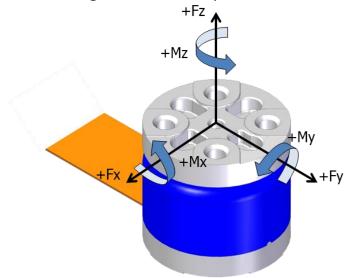
Fig. 24 Dimensions

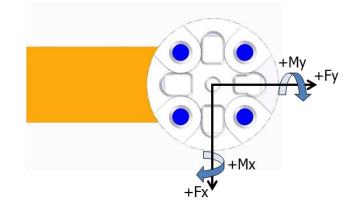
- Recommended FPC connector
- FH52K-20S-0.5SH (HIROSE ELECTRIC CO.,LTD)
- FH28D-20S-0.5SH (HIROSE ELECTRIC CO., LTD)
- 046288020600846+ (KYOCERA Corporation)

MMS101

# Sensor coordination systems

\*The origin is the sensor top surface center.





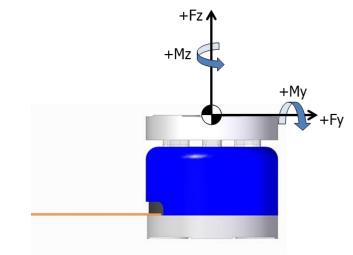
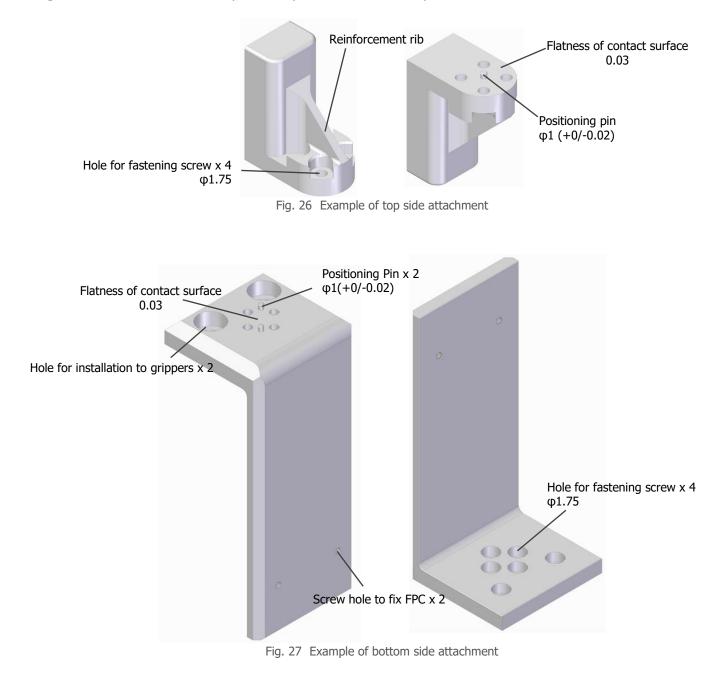


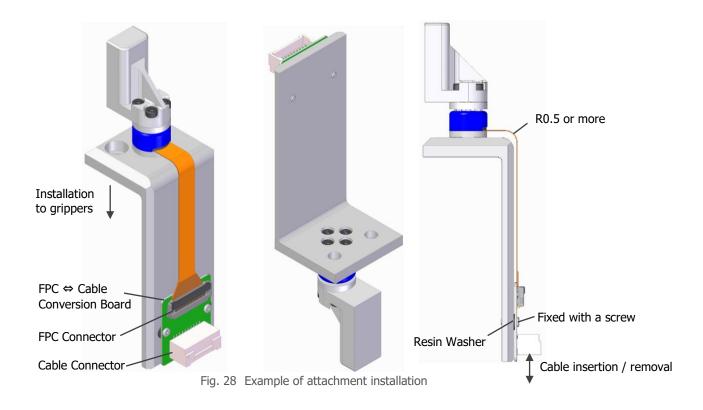
Fig. 25 Sensor coordination systems

Example of sensor attachment

It is important to minimize the attachment deformation during load application not to affect the sensor output. Therefore, the attachment should be designed to be hardly deformed by the load assumed in the normal use, using highly rigid materials such as SUS.

Fig. 26, 27 and 28 show examples of top & bottom side shape and installation of the attachment.





It is recommended to fix the board connected to FPC to the attachment with a screw so that the FPC is not bent repeatedly. Additionally, cables should be inserted and removed with the FPC fixed to the attachment with a screw to minimize load to the FPC.

Fig. 26, 27 and 28 show examples. The attachment should be designed depending on the intended use.

#### PRECAUTIONS FOR SENSOR INSTALLATION

This product is a precision measuring instrument. Therefore, it needs to be installed following the appropriate procedure to avoid overload to it. Failure to observe the recommendations included in this manual may cause damage to the sensor.

#### Installation screw

Four M1.6 screws should be used for installation on both top and bottom surfaces. **Length of the screws inserted in the installation holes of both surfaces should be 1.7 mm or shorter.** The tapped holes are 1.8 mm (min. 1.7 mm) through holes. Inserting a screw over 1.7 mm long could damage parts in the sensor.

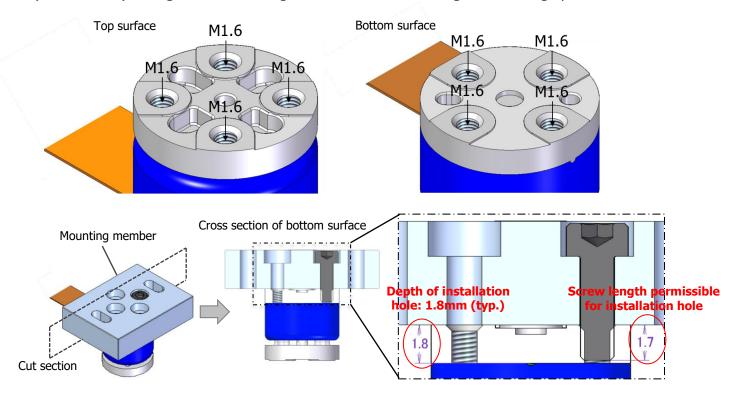


Fig. 29 Precautions for instllation screw

#### Positioning hole

For the top surface, a  $\varphi$ 1 round hole in the middle, a  $\varphi$ 1.7 round hole, or 1.6 x 1.45 mm square holes can be used for positioning. For the bottom surface, a  $\varphi$ 1 round hole and a  $\varphi$ 1 slotted hole can be used for positioning. For details, refer to "<u>DIMENSIONS</u>".

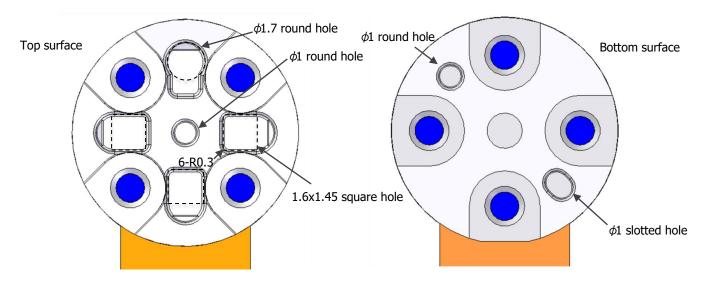


Fig. 30 Positioning holes

Recommended tightening method of sensor installation screw

The recommended tightening torque is 0.15N·m for M1.6 screws used to install this sensor. DO NOT fasten one screw tightly at first step, or the sensor may detect incorrect force and moment. In the worst case, the sensor could be damaged.

Screws must be fastened in the diagonal order as shown below. **First, they should be lightly fastened**, and then, fastened in more than 2 steps with the recommended tightening torque.

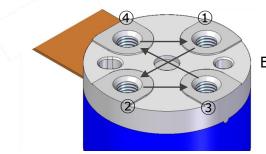


Fig. 31 Example of screw tightening order

Sensor contact surface

Flatness of the sensor side contact surface is 0.03mm, and the installation side contact surface should be designed at the same flatness. Level difference resulting from poor flatness could cause the force and the moment to be detected incorrectly. In the worst case, the sensor could be damaged. The installation side contact surface needs to be rigid enough against loads.

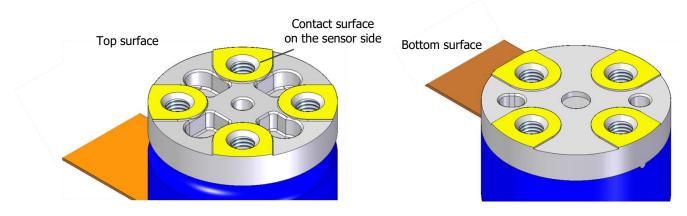


Fig. 32 Sensor side contact surface

#### PRECAUTIONS FOR SENSOR HANDLE

This product is a precision measuring instrument. Therefore, it needs to be handled following the appropriate procedure to avoid overload to it. Failure to observe the recommendations included in this manual may cause damage to the sensor.

#### Handling of sensor FPC

The FPC must NOT be strongly pulled in a lateral or the upper direction while the sensor body is fixed with screws. Otherwise, load is applied to the base of the FPC, and the wiring on the FPC might be snapped.

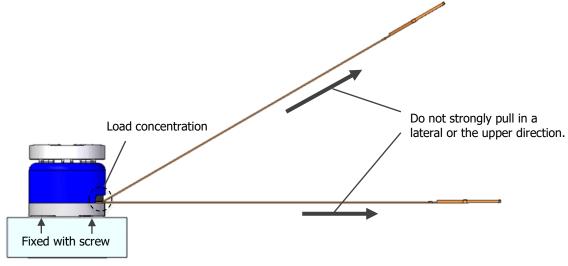
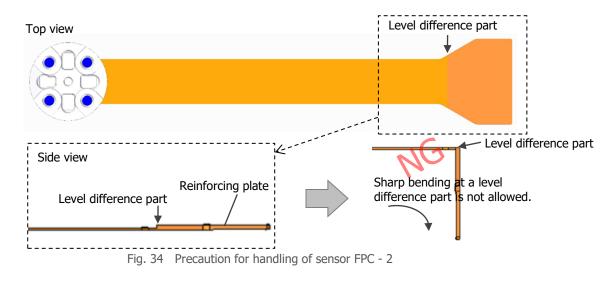


Fig. 33 Precaution for handling of sensor FPC - 1

In the FPC termination part, a level difference exists between the FPC and the reinforcing plate. Bending the FPC at this level difference part could cut the wiring on the FPC.

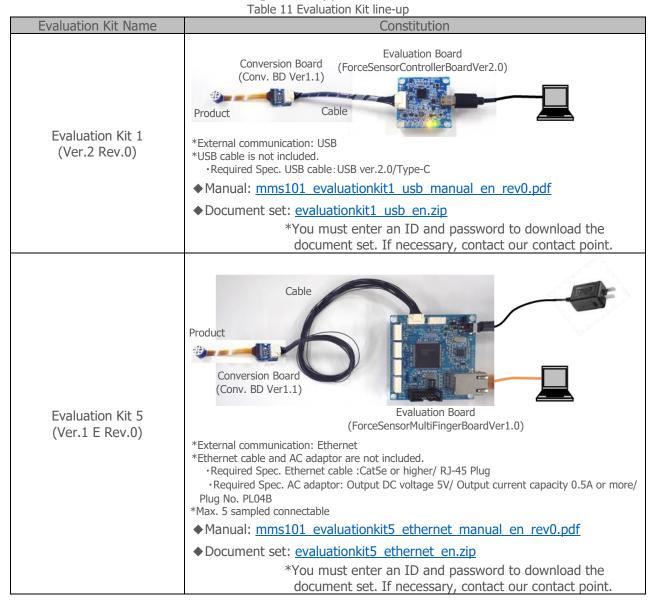


#### **OPTION**

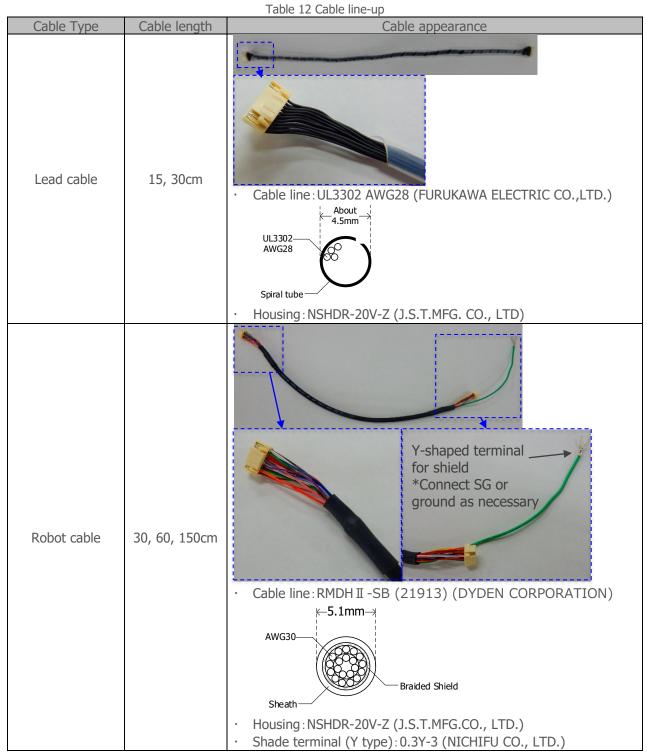
As options, evaluation kit and conversion board are available. Please order if necessary. However, the options are guaranteed only for checking the operation at the time of shipment, and will only be provided for sample support. Please note.

#### **Evaluation Kit**

Using evaluation kit with PC applications allows logging data to be acquired. In addition to product to which conversion board for evaluation kit are connected, they consist of cables and evaluation board. There are two kinds of evaluation kits. Select them according to the application.



Cable



		Ta		on Board line-up
Board Name	External Communication	Power Supply	No. of connectable sensors	Board appearance
ForceSensor ControllerBoard Ver2.0	USB	USB	Max. 1 pcs	40mm 40mm 40mm 40mm 40mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm 6.1mm
ForceSensor MultiFingerBoard Ver1.0	Ethernet	DC Jack	Max. 5 pcs	70mm         Image: State of the state

#### **Conversion Board**

Conversion Board is intended to connect a cable to this product. Connect the product terminal to the FPC connector and convert it to a cable connector with the number of pins according to the application.

	ersion board line-up				
Board Name	Terminal conversion table			ble	Board appearance
Conv. BD Ver1.1 (For Evaluation Kit)	MMS101 Output VDD VDDIO VLDOOUT SG FG FG FG SCLK SDI CSB_Fx CSB_Fy	20; Conv.BD Output VDDIO VLDOOUT SG FG N.C. SCLK SDI CSB_Fx CSB_Fy	Din MMS101 Output CSB_Fz CSB_Mx CSB_My CSB_My SDO_Fx SDO_Fx SDO_Fz SDO_Fz SDO_Mx SDO_My SDO_Mz	Conv.BD Output CSB_Fz CSB_Mx CSB_My CSB_Mz SDO_Fx SDO_Fy SDO_Fz SDO_Fz SDO_Mx SDO_My SDO_Mz	20mm ↓ 17mm 0.5mm ↓ 6.1mm • Sensor side connector : FH52K-20S-0.5SH (HIROSE ELECTRIC CO.,LTD) • Controll/Evaluation board side connector : SM20B-NSHDZS (J.S.T.MFG. CO., LTD.)

Table 14 Conversion board line-up

# NOTES

[Safety Precautions]

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- This product is intended for applying to computers, OA units, communication units, instrumentation units, machine tools, industrial robots, AV units, household electrical appliances, and other general electronic units.
- If you have any intentions to apply this product to the units related to the control and safety of transportation units (vehicles, trains, etc.), traffic signaling units, disaster-preventive & burglar-proof units, or the like, contact our sales representatives in advance.
- Don't apply this product to any aeronautical & space systems, submarine repeaters, nuclear power controllers, medical units involving the human life, Military-related equipment, or the like.
- Before using this product, even when it is not used for the usage written above, notify and present us beforehand if special care and attention are needed for its application, intended purpose, environment of usage, risk, and the design or inspection specification corresponding to them.
- If any damage to our customer is objectively identified to be caused by the defect of this product, Mitsumi is responsible for it. In this case, Mitsumi is liable for the cost limited to the delivery price of this product.

[Application considerations during actual circuit design]

- The outline of parameters described herein has been chosen as an explanation of the standard parameters and performance of the product. When you actually plan to use the product, please ensure that the outside conditions are reflected in the actual circuit and assembling designs.
- Before using this product, please evaluate and confirm the actual application with this product mounted and embedded.
- To investigate the influence by applied transient load or external noise, it is necessary to evaluate and confirm them with mounting this product to the actual application.
- Any usage above the maximum rating may destroy this product or shorten the lifetime. Be sure to use this product under the maximum rating.
- If you continue to use this product highly-loaded (applying high temperature, large current or high voltage; or variation of temperature) even under the absolute maximum rating and even in the operating range, the reliability of this product may decrease significantly. Please design appropriate reliability in consideration of power dissipation and voltage corresponding to the temperature and designed lifetime after confirming our individual reliability documents (such as reliability test report or estimated failure rate). It is recommended that, before using this product, you appropriately derate the maximum power dissipation (typically, 80% or less of the maximum value) considering parameters including ambient temperature, input voltage, and output current.

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[Others]

- Any part of the contents contained herein must not be reprinted or reproduced without our prior permission.
- In case of any question arises out of the description in this specification, it shall be settled by the consultation between both parties promptly.

# ATTENTION

- This product is designed and manufactured with the intention of normal use in general electronics. No special circumstance as described below is considered for the use of it when it is designed. With this reason, any use and storage under the circumstances below may affect the performance of this product. Prior confirmation of performance and reliability is requested to customers.
   Environment with strong static electricity or electromagnetic wave
  - Environment with high temperature or high humidity where dew condensation may occur
- This product is not designed to withstand radioactivity, and must avoid using in a radioactive environment.

# ADDITIONAL NOTES

- In the event of any defect in this product, you may send us the product. Then, we will perform an
  appropriate analysis and consult with you about appropriate remedy for the problem proposed by our sole
  discretion.
- Handle with care to prevent foreign matter from entering the screw holes and product gaps.
- When installing this product, design it so that the length of the screw inserted into the product mounting hole is 1.7mm or less. The product mounting hole is a through hole. If it exceeds 1.7mm, the internal parts will be damaged or malfunction. Also, we recommend that the tightening torque of the screws during mounting be 0.15N·m.
- Do not bend the FPC at a sharp angle or pull it hard so that the load is concentrated. Otherwise, the wiring on the FPC may be broken, resulting in operation failure.

# MITSUMI ELECTRIC CO., LTD.

Strategy Engineering Department Semiconductor Business Division

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Notes:

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